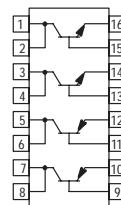


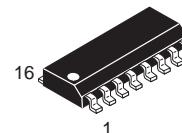
# Quad MPU Clock Buffer Transistor

NPN/PNP Silicon



**MMPQ6842**

Voltage and current are negative  
for PNP transistors



CASE 751B-05, STYLE 4  
SO-16

## MAXIMUM RATINGS

Rating	Symbol	Value		Unit
Collector-Emitter Voltage	$V_{CEO}$	30		Vdc
Collector-Base Voltage	$V_{CB}$	30		Vdc
Emitter-Base Voltage	$V_{EB}$	4.0		Vdc
Collector Current — Continuous	$I_C$	200		mAdc
		Each Transistor	Four Transistors Equal Power	
Total Power Dissipation @ $T_A = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	0.4 3.2	0.72 6.4	Watts mW/ $^\circ\text{C}$
Total Power Dissipation @ $T_C = 25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	0.66 5.3	1.92 15.4	Watts mW/ $^\circ\text{C}$
Operating and Storage Junction Temperature Range	$T_J, T_{stg}$	−55 to +150		$^\circ\text{C}$

## ELECTRICAL CHARACTERISTICS ( $T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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## OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage(1) ( $I_C = 10 \text{ mAdc}$ , $I_B = 0$ )	$V_{(BR)CEO}$	30	—	—	Vdc
Collector-Base Breakdown Voltage ( $I_C = 10 \mu\text{Adc}$ , $I_E = 0$ )	$V_{(BR)CBO}$	30	—	—	Vdc
Emitter-Base Breakdown Voltage ( $I_E = 10 \mu\text{Adc}$ , $I_C = 0$ )	$V_{(BR)EBO}$	4.0	—	—	Vdc
Collector Cutoff Current ( $V_{CB} = 20 \text{ Vdc}$ , $I_E = 0$ )	$I_{CBO}$	—	—	50	nAdc
Emitter Cutoff Current ( $V_{EB} = 3.0 \text{ Vdc}$ , $I_C = 0$ )	$I_{EBO}$	—	—	50	nAdc

1. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ ; Duty Cycle  $\leq 2.0\%$ .

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (Continued)

Characteristic	Symbol	Min	Typ	Max	Unit
<b>ON CHARACTERISTICS(1)</b>					
DC Current Gain ( $I_C = 0.5 \text{ mA}_\text{dc}$ , $V_{CE} = 1.0 \text{ V}_\text{dc}$ ) ( $I_C = 1.0 \text{ mA}_\text{dc}$ , $V_{CE} = 1.0 \text{ V}_\text{dc}$ ) ( $I_C = 10 \text{ mA}_\text{dc}$ , $V_{CE} = 1.0 \text{ V}_\text{dc}$ )	$h_{FE}$	30 50 70	— — —	— — —	—
Collector-Emitter Saturation Voltage ( $I_C = 0.5 \text{ mA}_\text{dc}$ , $I_B = 0.05 \text{ mA}_\text{dc}$ , $0^\circ\text{C} \leq T \leq 70^\circ\text{C}$ )	$V_{CE(\text{sat})}$	—	0.05	0.15	$\text{V}_\text{dc}$
Base-Emitter Saturation Voltage ( $I_C = 0.5 \text{ mA}_\text{dc}$ , $I_B = 0.05 \text{ mA}_\text{dc}$ )	$V_{BE(\text{sat})}$	—	0.65	0.9	$\text{V}_\text{dc}$

**DYNAMIC CHARACTERISTICS**

Current-Gain — Bandwidth Product <sup>(1)</sup> ( $I_C = 10 \text{ mA}_\text{dc}$ , $V_{CE} = 20 \text{ V}_\text{dc}$ , $f = 100 \text{ MHz}$ )	$f_T$	200	350	—	MHz
Output Capacitance ( $V_{CB} = 5.0 \text{ V}_\text{dc}$ , $I_E = 0$ , $f = 1.0 \text{ MHz}$ )	$C_{ob}$	—	3.0	4.5	pF
Input Capacitance ( $V_{EB} = 0.5 \text{ V}_\text{dc}$ , $I_C = 0$ , $f = 1.0 \text{ MHz}$ )	$C_{ib}$	— —	5.0 4.0	10 8.0	pF

**SWITCHING CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$ ,  $V_{CC} = 5.0 \text{ V}_\text{dc}$ )

Propagation Delay Time (50% Points TP1 to TP3) (50% Points TP2 to TP4)	$t_{PLH}$ $t_{PHL}$	— —	15 6.0	25 15	ns
Rise Time (0.3 V to 4.7 V, TP3 or TP4)	$t_r$	5.0	25	35	ns
Fall Time (4.7 V to 0.3 V, TP3 or TP4)	$t_f$	5.0	10	20	ns

1. Pulse Test: Pulse Width  $\leq 300 \mu\text{s}$ ; Duty Cycle  $\leq 2.0\%$ .